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HEET 1 OF 1

Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		New US PCT Application based on PCT/JP05/00976			
(Modified)		PATENT AND TRA	DEMARK OFFICE	294236US0X PCT					
				APPLICANT					
LIST OF	REFE	RENCES CITED BY AF	PLICANT	Tetsuhiko ISOBE, et al.					
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U.S. PATENT DOCUMENTS									
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		DOCUMENT NUMBER	DATE	COUNTRY		YES	TRANSLATIO S	N NO	
	AO	11 181419	07/06/99	JP (English abstract only)				NO	
	AP	10 168442	06/23/98	JP (English abstract only and equivalent 6093492)	t of US			NO	
	AQ	2002 121549	04/26/02	JP (English abstract only)				NO	
	AR	9 127686	05/16/97	JP (English abstract only and equivalen 6077647)	tofus			NO	
	AS	2000 204368	07/25/00	JP (English abstract only)				NO	
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		OTHER R	EFERENCES ((Including Author, Title, Date, Pertinent	Pages, e	tc.)			
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Examiner	Examiner /C. Melissa Koslow/					Date Considered 10/03/2008			
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